

Special Issue

Advanced III-Nitride Technologies for Power and RF Applications: Recent Breakthroughs and Future Prospects

Message from the Guest Editor

Wide- and ultrawide-bandgap III-nitride semiconductors (GaN, Al_xGa_{1-x}N, AlN) exhibit remarkable properties that position them as pivotal materials in the production of next-generation power and RF electronic devices. The focus of this Special Issue is to provide a comprehensive overview of the most recent advances in the realm of III-nitride-based semiconductors, encompassing innovative device architecture, carrier transport, and emerging trends. The scope of this Special Issue extends across a diverse array of subjects. These include but are not limited to the following areas:

- Vertical and lateral III-nitride based unipolar and bipolar devices for efficient power electronics and/or high frequency operation.
- Carrier transport: electron and hole gases, modeling, and simulation.
- Contact and gate stack engineering, novel field management designs.
- Monolithic integration of III-nitride devices in power integrated circuits.
- Reliability and thermal management of III-nitride devices.
- III-nitride devices for radiation hard electronics.

Guest Editor

Dr. Chandan Joishi

Department of Electrical and Computer Engineering, The Ohio State University, Columbus, OH 43210 USA

Deadline for manuscript submissions

closed (15 August 2024)



Electronics

an Open Access Journal
by MDPI

Impact Factor 2.6
CiteScore 6.1



mdpi.com/si/188321

Electronics
Editorial Office
MDPI, Grosspeteranlage 5
4052 Basel, Switzerland
Tel: +41 61 683 77 34
electronics@mdpi.com

[mdpi.com/journal/
electronics](https://mdpi.com/journal/electronics)





Electronics

an Open Access Journal
by MDPI

Impact Factor 2.6
CiteScore 6.1



[mdpi.com/journal/
electronics](https://mdpi.com/journal/electronics)



About the Journal

Message from the Editor-in-Chief

Electronics is a multidisciplinary journal designed to appeal to a diverse audience of research scientists, practitioners, and developers in academia and industry. The journal is devoted to fast publication of latest technological breakthroughs, cutting-edge developments, and timely reviews of current and emerging technologies related to the broad field of electronics. Experimental and theoretical results are published as regular peer-reviewed articles or as articles within Special Issues guest-edited by leading experts in selected topics of interest.

Editor-in-Chief

Prof. Dr. Flavio Canavero

Department of Electronics and Telecommunications, Politecnico di
Torino, 10129 Torino, Italy

Author Benefits

High Visibility:

indexed within Scopus, SCIE (Web of Science), CAPus /
SciFinder, Inspec, Ei Compendex and other databases.

Journal Rank:

JCR - Q2 (Engineering, Electrical and Electronic) /
CiteScore - Q1 (Electrical and Electronic Engineering)

Rapid Publication:

manuscripts are peer-reviewed and a first decision is provided to authors approximately 16.8 days after submission; acceptance to publication is undertaken in 2.4 days (median values for papers published in this journal in the first half of 2025).